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APT30DQ60BG

Datasheet Ultrafast Soft Recovery Rectifier Diode

Final March 2018



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1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision E

Revision E was published in March 2018. The new Microsemi template and format was applied. The package outline drawing was updated. For more information, see Package Outline Drawing (see page 8).

1.2 Revision D

Revision D was published in May 2011. The patent information was removed from the document. For TO-247 packages: the maximum lead thickness was changed from 0.70 in (0.031 mm) to 1.016 in (0.040 mm).

1.3 Revision C

Revision C was published in July 2010. The update included adding E1 and E3 notes to the back page.

1.4 Revision B

Revision B was published in December 2005. Information was updated to add full characterization for the small die DQ 30A 600 V.

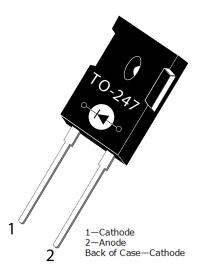
1.5 Revision A

Revision A was published in December 2004. It is the first publication of this document.



2 Product Overview

This section outlines the product overview for the APT30DQ60BG device.



2.1 Features

The following are key features of the APT30DQ60BG device:

- Ultrafast recovery times
- Soft recovery characteristics
- Low forward voltage
- Low leakage current
- Avalanche energy rated
- RoHS compliant
- AEC-Q101 qualified

2.2 Benefits

The following are benefits of the APT30DQ60BG device:

- High switching frequency
- Low switching losses
- Low noise (EMI) switching
- Higher reliability systems
- Increased system power density

2.3 Applications

The APT30DQ60BG device is designed for the following applications:

- Power factor correction (PFC)
- Anti-parallel diode
 - Switch-mode power supply
 - Inverters/converters
 - Motor controllers
- Freewheeling diode
 - Switch-mode power supply
 - Inverters/converters
- Snubber/clamp diode



3 Electrical Specifications

This section outlines the electrical specifications for the APT30DQ60BG device.

3.1 Absolute Maximum Ratings

The following table shows the absolute maximum ratings for the APT30DQ60BG device.

All ratings: Tc = 25 °C unless otherwise specified.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
VR	Maximum DC reverse voltage	600	
Vrrm	Maximum peak repetitive reverse voltage	600	V
VRWM	Maximum working peak reverse voltage	600	
F(AV)	Maximum average forward current (Tc = 117 °C, duty cycle = 0.5)	30	
F(RMS)	RMS forward current	51	— A
IFSM	Non-repetitive forward surge current (TJ = 45 °C, 8.3 ms)	320	
Eavl	Avalanche energy (1 A, 40 mH)	20	mJ
Tj , T stg	Operating and storage temperature range	-55 to 175	°C
Τι	Lead temperature for 10 s	300	_

3.2 Electrical Performance

The following table shows the static electrical characteristics of the APT30DQ60BG device.

Table 2 • Static Electrical Characteristics

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	Unit	
VF	Forward voltage	IF = 30 A		2.0	2.4	V	
VF		IF = 60 A		2.4		- v	
		IF = 30 A, TJ = 125 °C		1.7			
Irm	Maximum reverse leakage current	V _R = 600 V			25	μΑ	
		V _R = 600 V, T _J = 125 °C			500	_	
C⊤	Junction capacitance	V _R = 200 V		36		pF	



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The following table shows the dynamic characteristics of the APT30DQ60BG device.

Symbol	Characteristic	Test Conditions	MIN	ТҮР	MAX	Unit
trr	Reverse recovery time	IF = 30 A		23		ns
		dir/dt = -200 A/µs				
		V _R = 400 V				
		Tc = 25 °C				
trr	Reverse recovery time	IF = 30 A		30		-
Qrr	Reverse recovery charge	 dir/dt = -200 A/μs V_R = 400 V T_c = 25 °C 		55		nC
Irrm	Maximum reverse recovery current			3		А
trr	Reverse recovery time	$I_{F} = 30 \text{ A}$ = di_F/dt = -200 A/µs _ V_R = 400 V T_C = 125 °C		175		ns
Qrr	Reverse recovery charge			485		nC
Irrm	Maximum reverse recovery current			6		А
trr	Reverse recovery time	IF = 30 A		75		ns
Qrr	Reverse recovery charge	di⊧/dt = −1000 A/μs V _R = 400 V		855		nC
IRRM	Maximum reverse recovery current	Tc = 125 °C		22		А

Table 3 • Dynamic Characteristics

The following table shows the thermal and mechanical characteristics of the APT30DQ60BG device.

Table 4 • Thermal and Mechanical Characteristics

Symbol	Characteristic / Test Conditions	MIN	ТҮР	MAX	Unit
Rөлс	Junction-to-case thermal resistance			0.80	°C/W
WT	Package weight		0.22		OZ
			5.9		g
Torque	Maximum mounting torque				lb∙m
				1.1	N∙m



3.3 Typical Performance Curves

This section shows the typical performance curves for the APT30DQ60BG device.

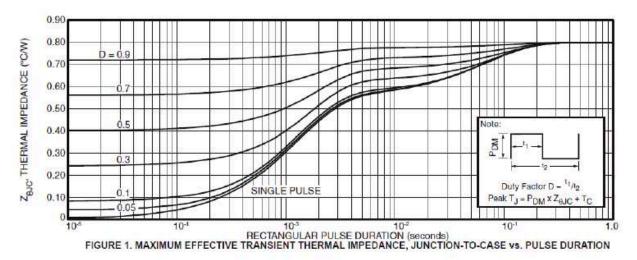


Figure 1 • Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse



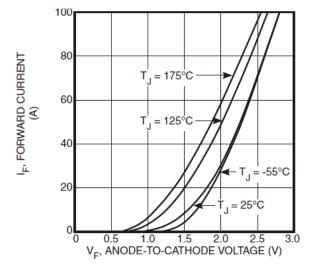
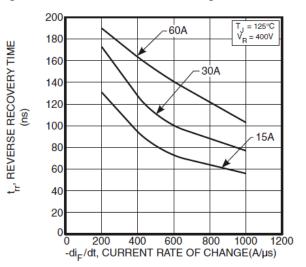


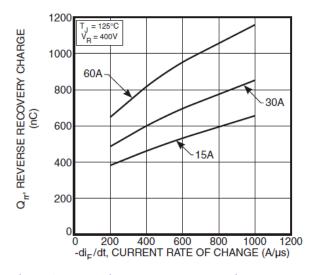
Figure 3 • trr vs. Current Rate of Change





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Figure 4 • Qrr vs. Current Rate of Change





Temperature

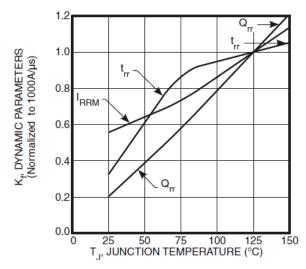


Figure 8 • Junction Capacitance vs. Reverse Voltage

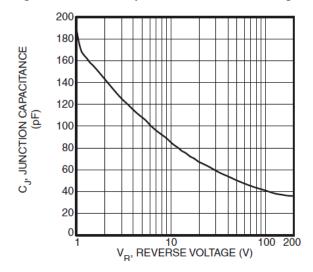


Figure 5 • Irrm vs. Current Rate of Change

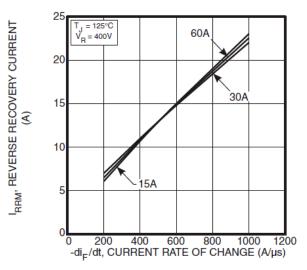
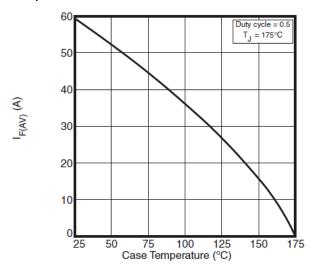


Figure 7 • Maximum Average Forward Current vs. Case Temperature





3.4 Reverse Recovery Overview

The following illustration shows the reverse recovery testing and measurement information for the APT30DQ60BG device.

Figure 9 • Diode Test Circuit

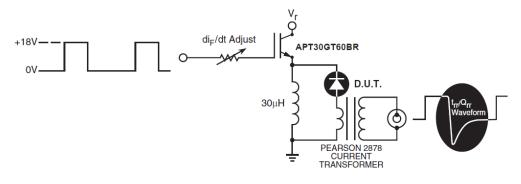
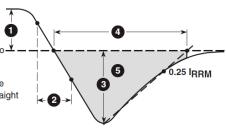


Figure 10 • Diode Reverse Recovery Waveform and Definitions

- I_F Forward Conduction Current
 di_F/dt Rate of Diode Current Change Through Zero Crossing.
 I_{RRM} Maximum Reverse Recovery Current.
 t_{rr} Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and 0.25•I_{RRM} passes through zero.
- 5 Qrr Area Under the Curve Defined by I_{RRM} and trr.





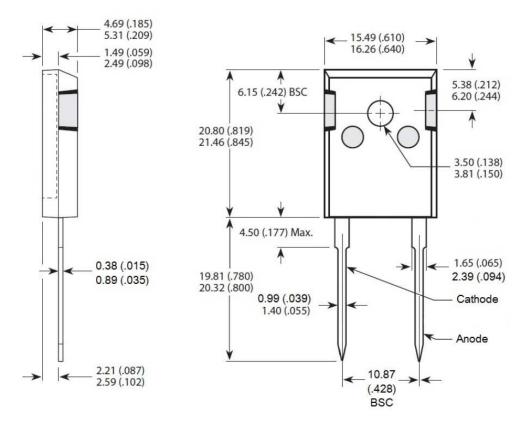
4 Package Specification

This section outlines the package specification for the APT30DQ60BG device.

4.1 Package Outline Drawing

This section details the TO-247 package drawing of the APT30DQ60BG device. Dimensions are in millimeters and (inches).

Figure 11 • TO 247 Package Outline







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